Issue	Classification

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/708,847	YAN, HAI	
Examiner	Art Unit	
Helen C. Kwok	2856	

	IS	SSUE CLASSIFICATION											
ORIGINAL		CROSS REFERENCE(S)											
CLASS SUBCLASS	CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)											
73 504.04	73	504.14											
INTERNATIONAL CLASSIFICATION													
G 0 1 C 19/00													
(Assistant Examiner) (Date	 e)	HELEN KWOK PRIMARY EXAMINER Total Claims Allowed: 9											
1 WW 1233	0'05	Helén C. Kwók 3/22/05 O.G. O.G. Print Claim(s) Print Fig.											
(Legal:Instruments:Examiner):::(Date)	(Primary Examiner) (Date) 1 6											

	Claims renumbered in the same order as presented by applicant							□ СРА			·□ T.D.			☐ R.1.47					
Final	Original		Final	Original		Final	Original		Final	Original		Final	Original		Final	Original		Final	Original
1	1			31			61			91			121		-	151			181
2	2			32			62			92			122	1		152			182
3	3			33			63			93			123			153			183
4	4			34			64			94			124			154			184
5	5			35			65		,	95			125			155			185
6	6			36			66			96			126	;		156			186
7	7			37			67			97			127			157			187
8	8			38			68			98			128			158			188
9	9			39			69			99			129			159			189
	10			40			70			100			130			160			190
	11			41			71			101			131			161			191
	12			42			72			102		n (8	132			162			192
	13			43			73			103			133	•		163			193
	14			44			74			104			134		•	164			194
	15			45			75	1		105			135			165			195
	16			46			76			106		_	136			166			196
	17			47			77	1		107			137			167			197
	18			48			78]		108	·		138			168			198
	19		,	49			79	1		109			139	•		169			199
	20			50	·		80			110	•		140	:		170			200
	21			51			81	1		111			141			171			201
	22			52	:		82			112			142			172			202
	23			53			83			113			143			173			203
	24			54	!		84			114			144			174			204
	25			55			85			115			145	į		175			205
	26			56			86			116			146	į		176			206
	27			57			87			117			147			177			207
	28			58			88			118	- 5		148			178		V 6	208
	29		1000	59			89			119			149			179			209
	30			60			90			120			150			180			210